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Radiation-hard Active Pixel Detectors based on HV-CMOS Technology for HL-LHC Detector Upgrades

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on behalf of the participating institutes:
**U. Bonn, CERN, CPPM Marseille, U.
Geneva, U. Glasgow, U. Heidelberg, LBNL**



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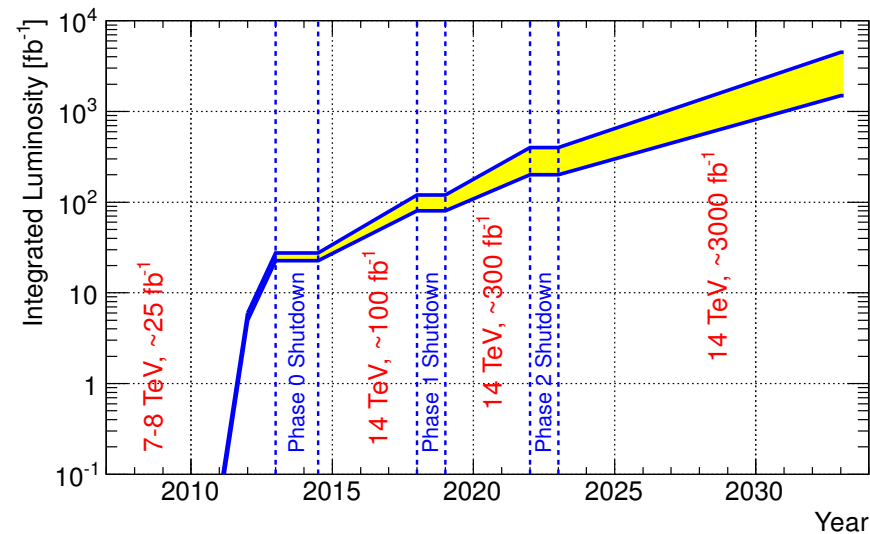
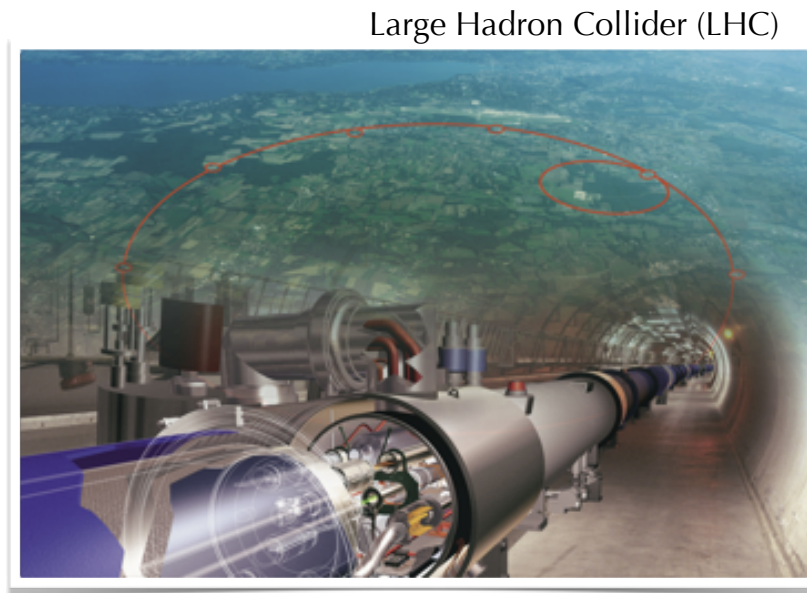
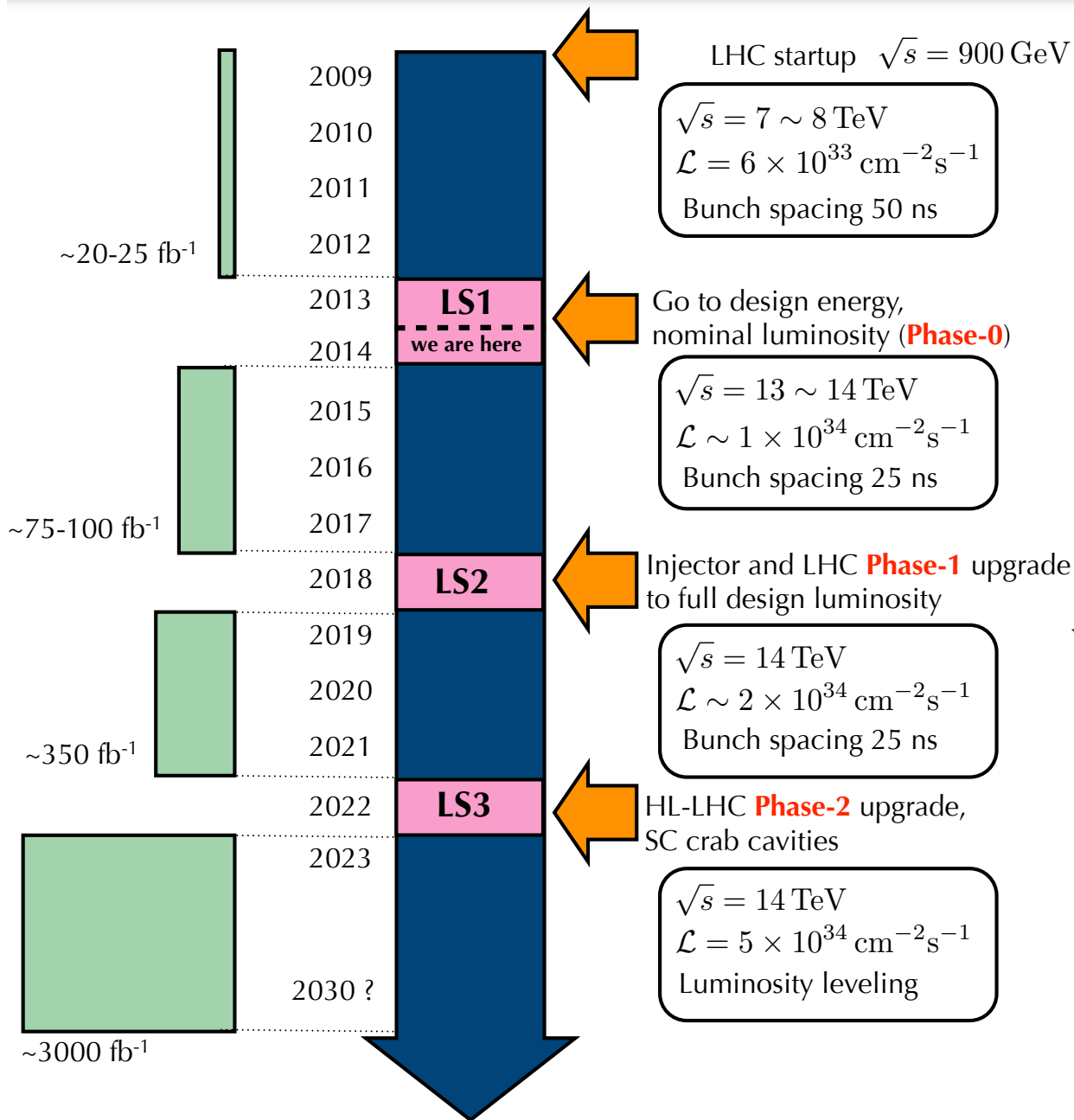
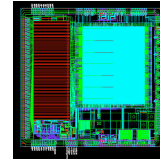
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The High-Luminosity LHC (HL-LHC)



HE-LHC: $\sqrt{s} = 33 \text{ TeV}$

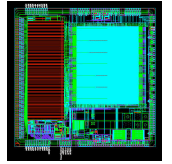
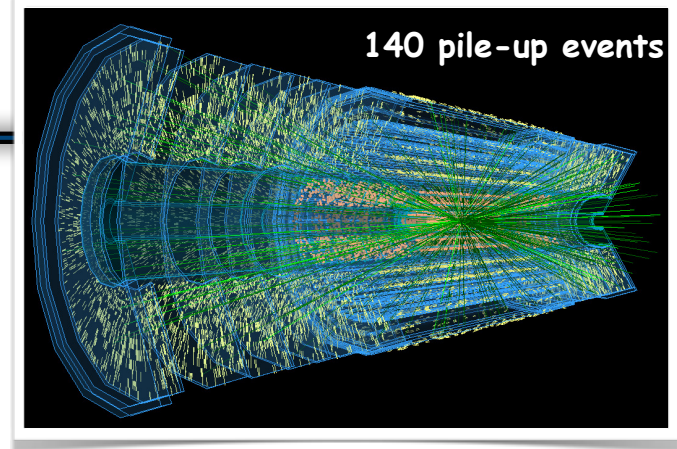
300 - 3000 fb⁻¹



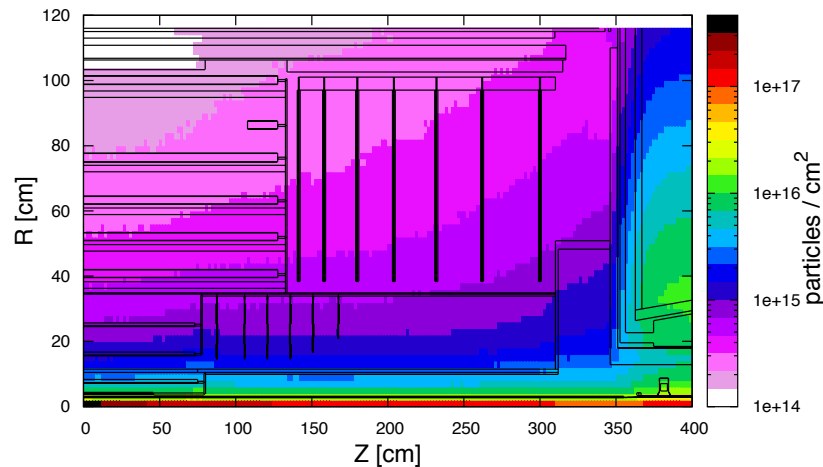
New ATLAS tracker

- Conditions at $5 \times 10^{34} \text{ cm}^{-2} \text{ s}^{-1}$:

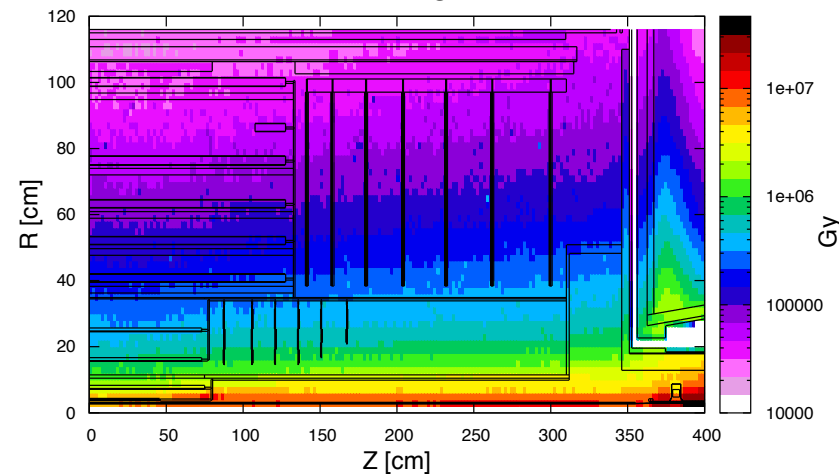
- ▶ radiation damage
- ▶ channel occupancy
 - particle multiplicity $> 10^5$ particles $|\eta| < 3.2$



1 MeV neutron equivalent fluence



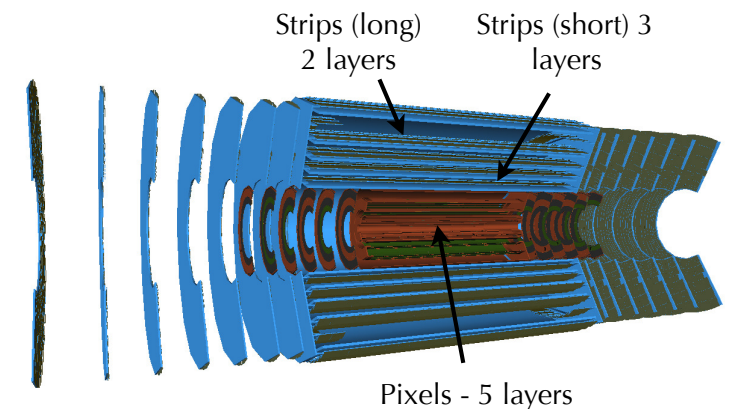
total ionising dose



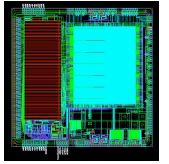
- New ATLAS Inner Detector

- silicon-based tracker (pixels + strips)

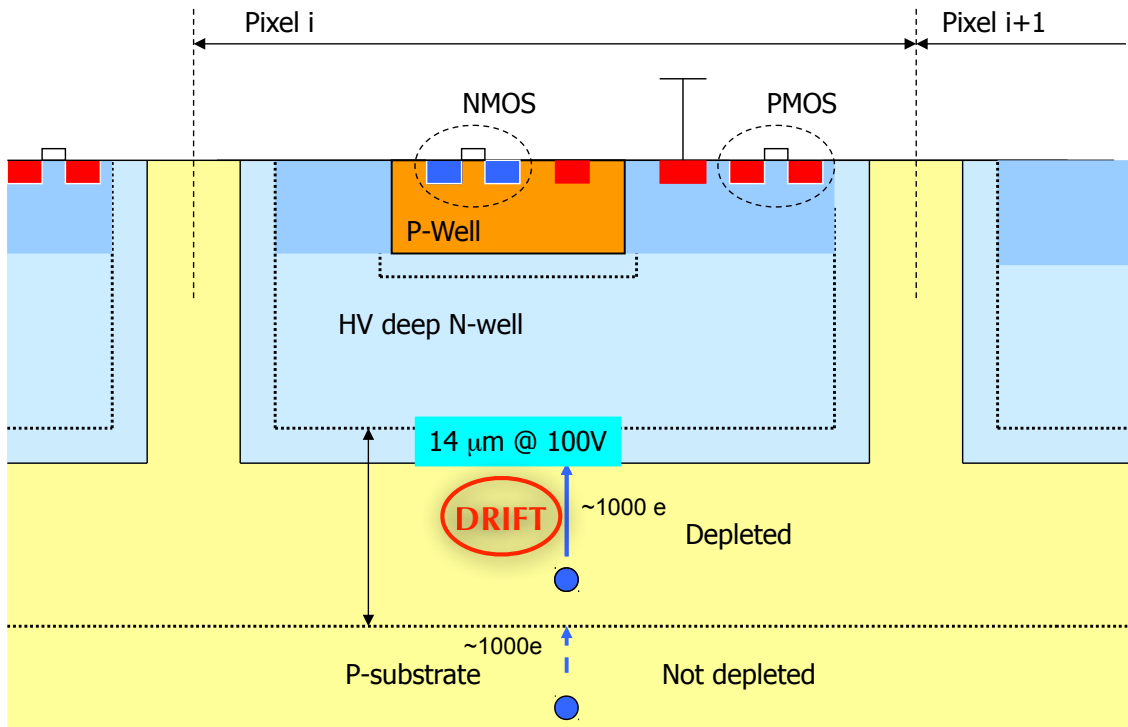
- ▶ maintain / improve current tracking capabilities
- ▶ better detector granularity, radiation hardness
- New Detectors: lowest price while rad-hard !
 - ▶ possibility of existing industrialized processes ?



High-Voltage CMOS



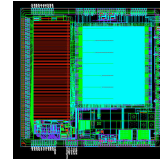
- High Voltage-CMOS (HV-CMOS) technology
 - ▶ standard industrialized process (low-cost, large availability)
- HV-CMOS as monolithic pixel particle detector
 - ▶ project initiated by I. Peric (U. Heidelberg)
 - ▶ sensor based on multiple-well structure
 - entire CMOS electronics inside the deep N-well → “smart diode” → “smart diode array”
 - ❖ PMOS transistors directly in the deep N-well
 - ❖ NMOS transistors within P-well embedded in deep N-well



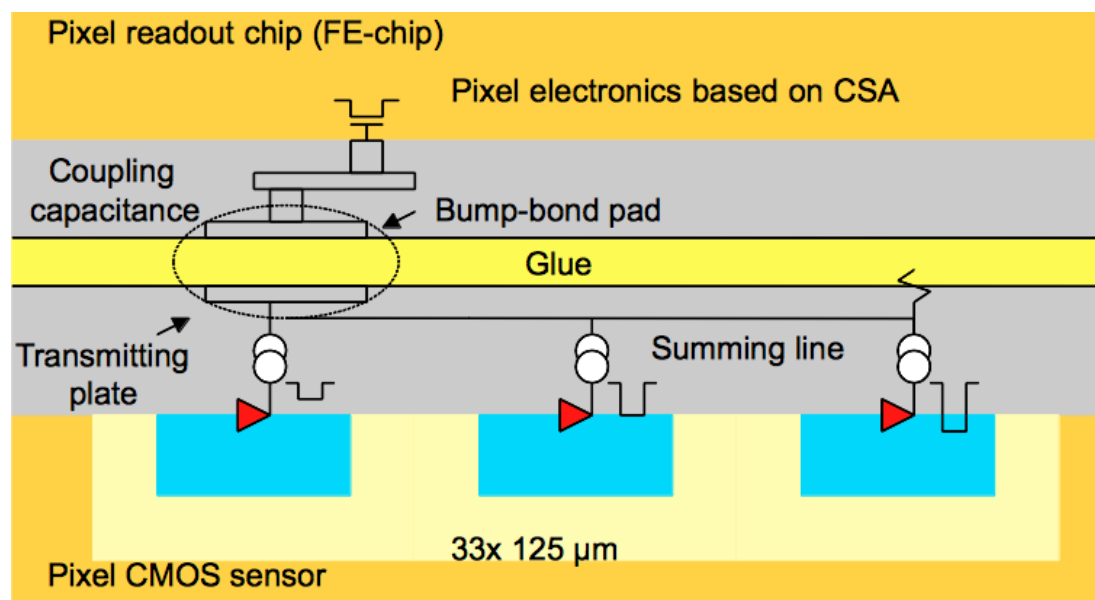
Technology	Austria Microsystems (AMS) + IBM 350 nm / 180 nm
Substrate resistivity	> 10 Ωcm
Pixel size	down to 20 μm
Depletion depth	~ 10 - 20 μm
Reverse bias voltage	~ 60 - 100 V
Charge collection time	~ 40 ps
Signal (mip)	~ 2000 e



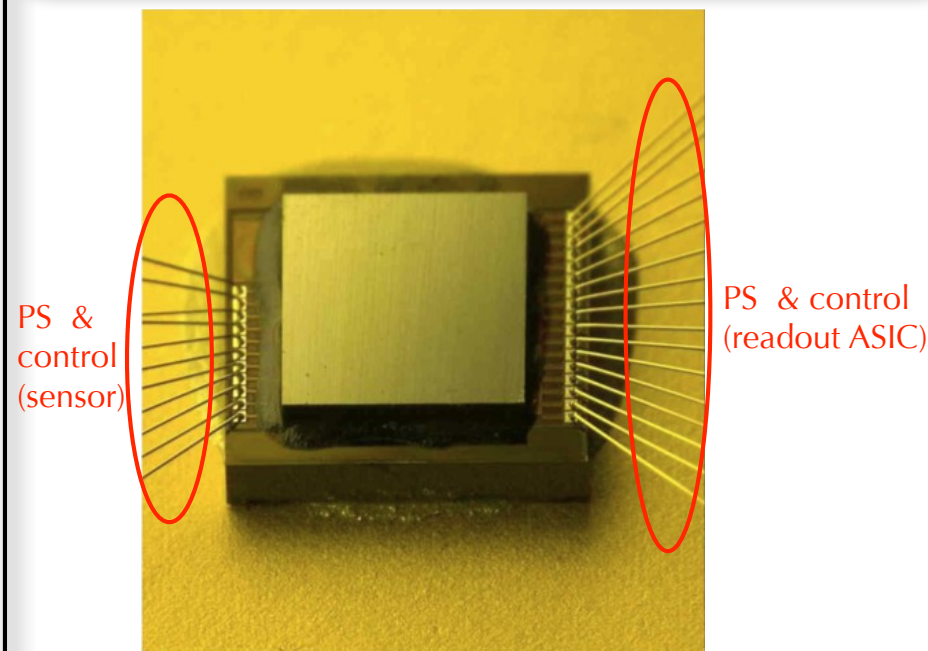
Capacitively coupled detector



- Implementation of on-sensor CMOS electronics (e.g. charge sensitive amplifier, etc.) → signal transmission by **capacitive (AC) coupling**
 - ▶ signal transmitted to the charge sensitive amplifier in the the readout ASIC
 - ▶ no need of costly bump-bonding process
- Gluing process:
 - ▶ alignment precision: $< 5 \mu\text{m}$
 - ▶ glue layer thickness: $< 5 \mu\text{m}$

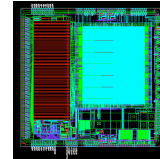


CCPD (Capacitive Coupled Pixel Detector)



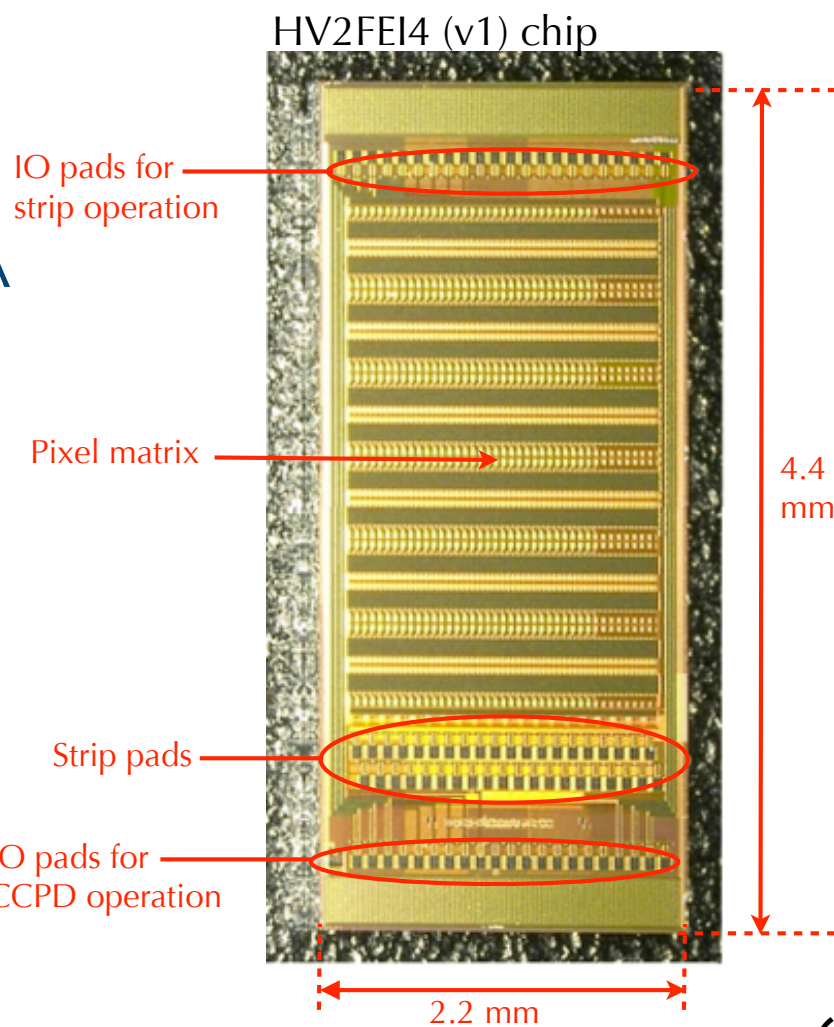
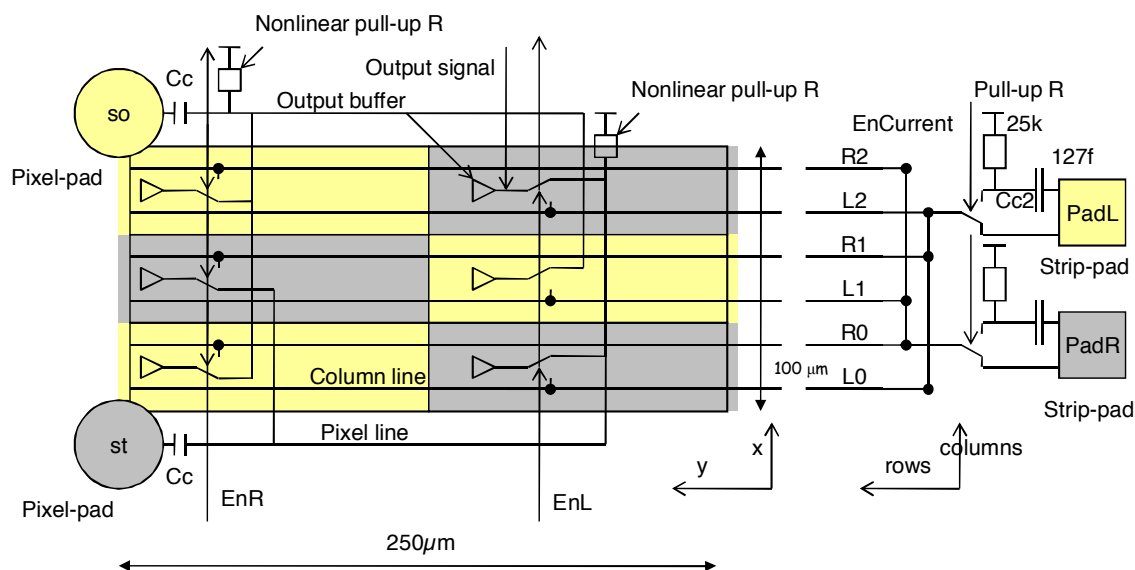
SNR: $\sim 45 - 60$

HV2FEI4 prototype chip

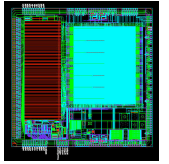


- Chip-size: 2.2x4.4 mm²
 - ▶ pixel matrix: 60x24 sub-pixels (unit cell = 6 pixels, each 125 x 33 μm²)
- HV2FEI4 compatible with:
 - ▶ ATLAS FEI4 (ATLAS pixel readout ASIC)
 - bump-bonding or capacitive coupling
 - ▶ strip readout
- Charge sensitive amplifier, discriminator
- On-chip bias DAC, configuration via FPGA

Unit cell structure of the HV2FEI4 prototype

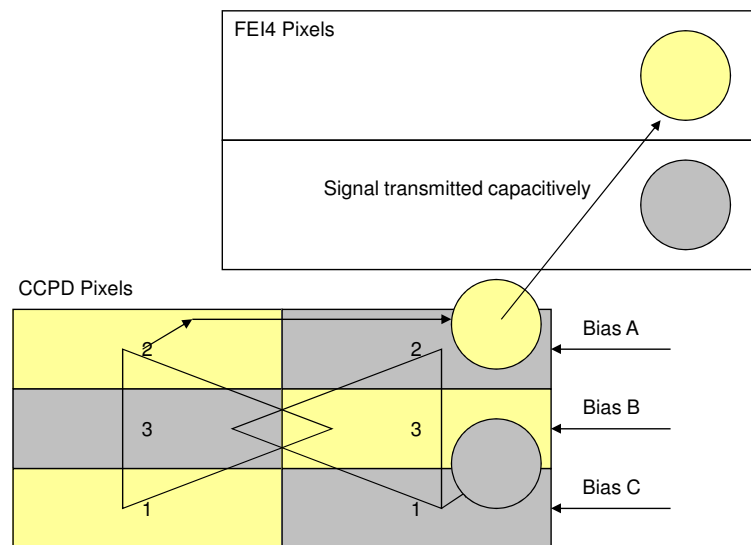


Readout modes

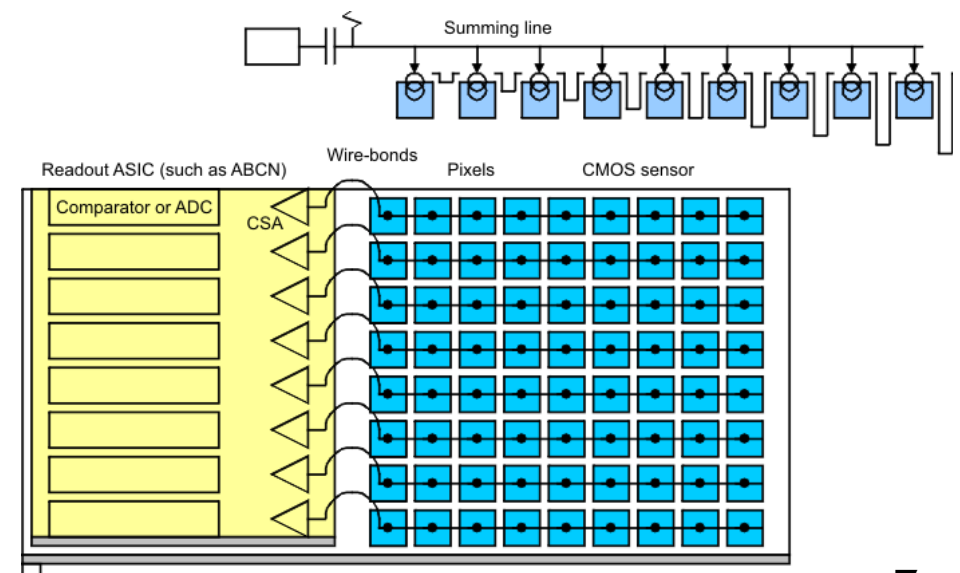


- Capacitively coupled readout chip
 - ▶ unit cell corresponding to two ATLAS FEI4 readout-chip pixels
 - ▶ combine sensor sub-pixels for AC readout
 - ▶ different current amplitude per pixel → hit position from pulse-height information
 - improvement in resolution without changes in readout chip
- Readout as a strip-like detector
 - ▶ sum all pixels in a row → “virtual strip”
 - multiple connections possible (crossed-strips)
 - ▶ hit position along strip encoded as pulse-height → Z-resolution improved

Pixel readout (AC coupling)

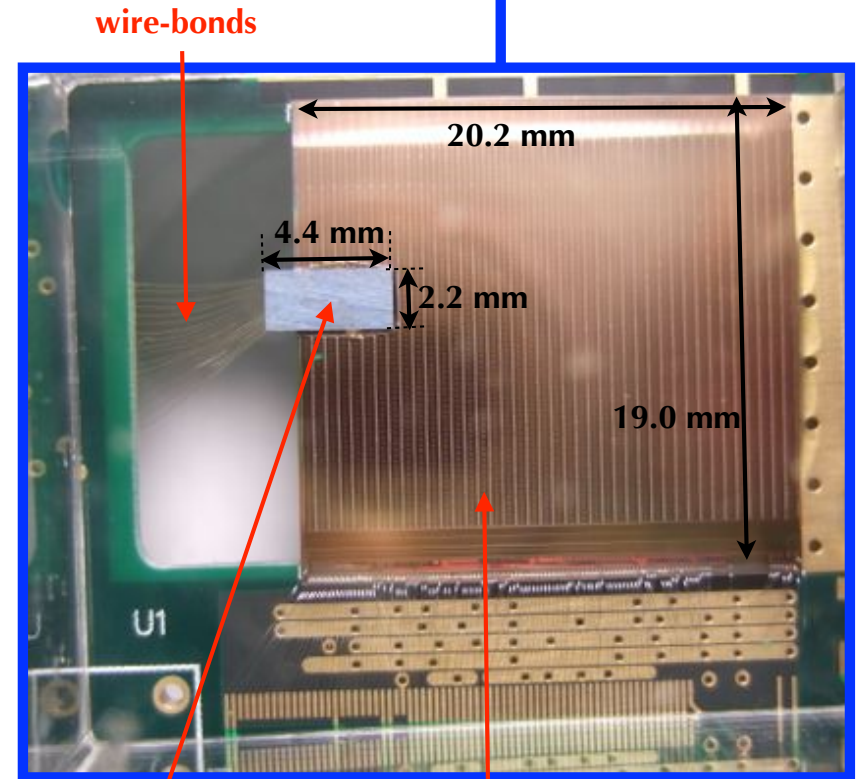
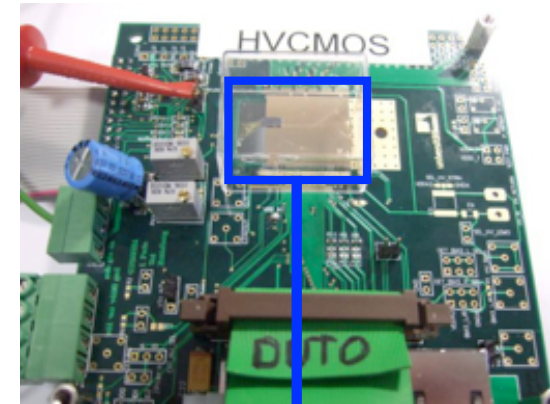
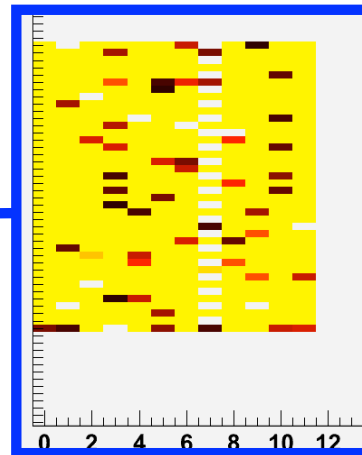
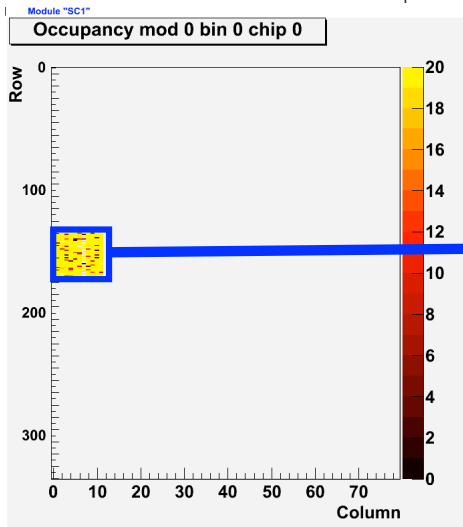
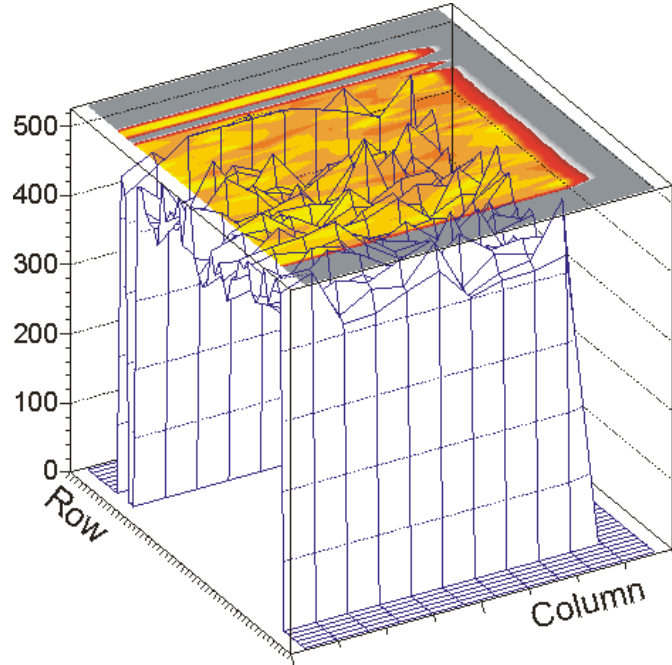


Strip readout



Pixel readout

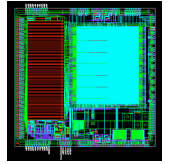
- FEI4 ASIC glued to HV-CMOS sensor
 - ▶ β^+ signal detection from ^{22}Na radioactive source



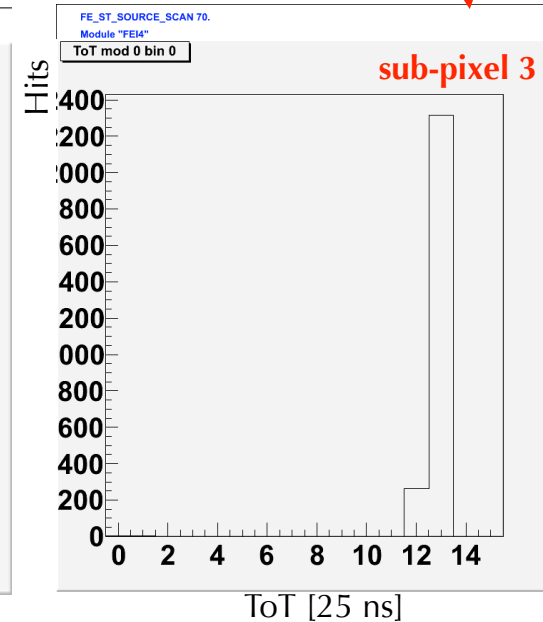
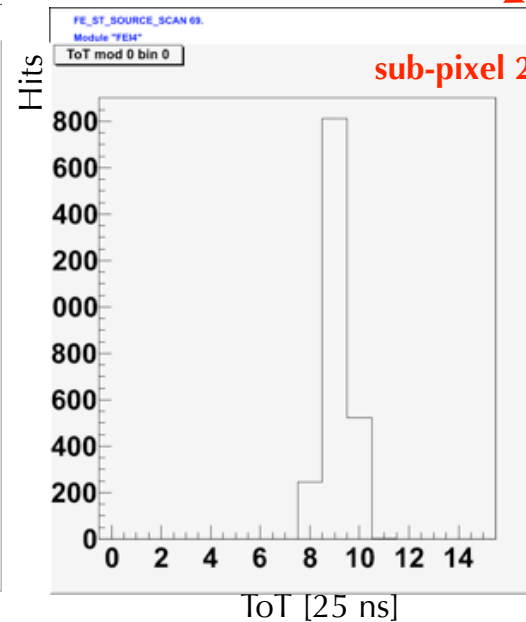
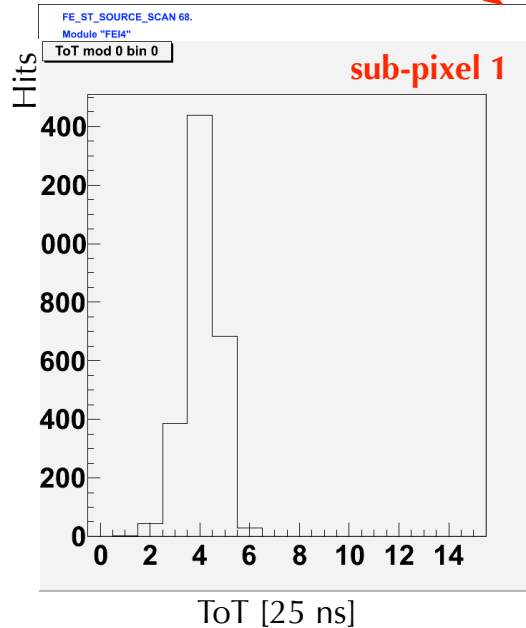
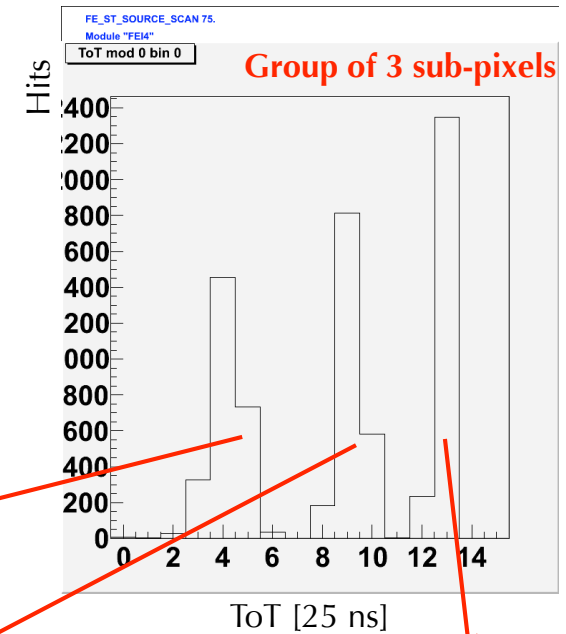
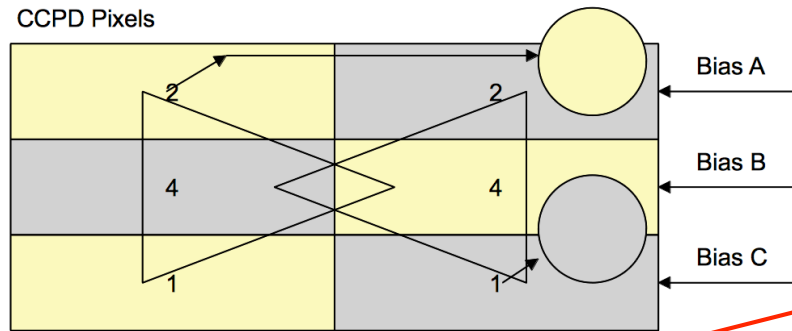
HV2FEI4
- pixel size: $125\ \mu\text{m} \times 33\ \mu\text{m}$
- 60 columns x 24 rows

FEI4 readout chip
- pixel size: $250\ \mu\text{m} \times 50\ \mu\text{m}$
- 80 columns x 336 rows

Sub-pixel encoding



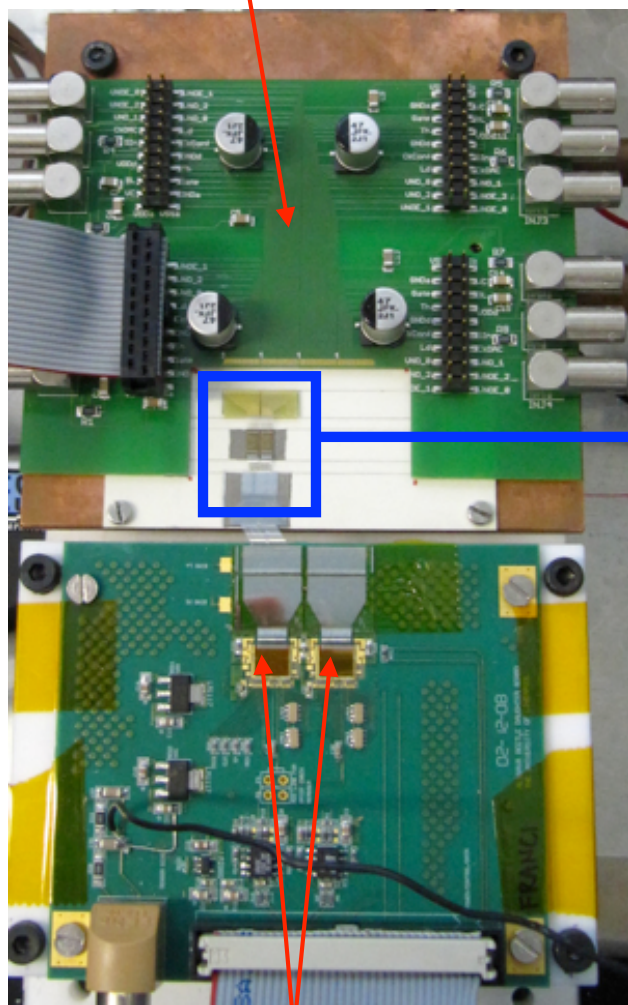
- FEI4 readout chip:
 - ▶ Time-Over-Threshold (ToT) information (4 bits)
- sub-pixels within group of three could be distinguished



Strip readout

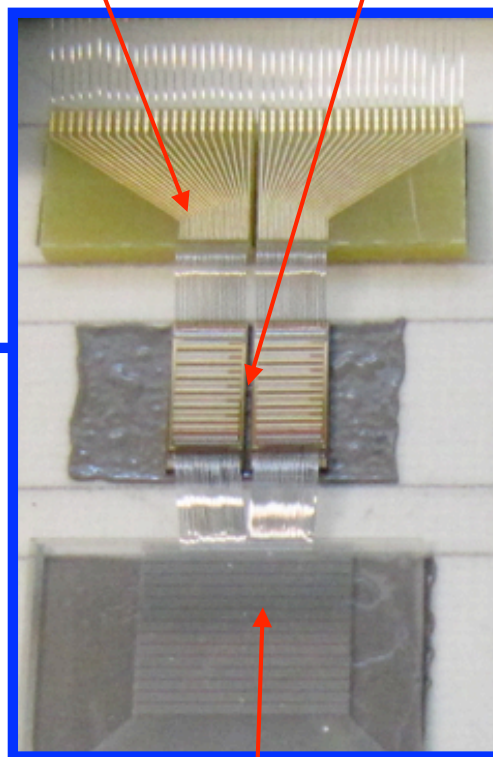
- Analog readout chip: BEETLE (LHCb velo)
- Proof-of-principle of position-encoding along virtual strip

Add-on PCB (bias & control)

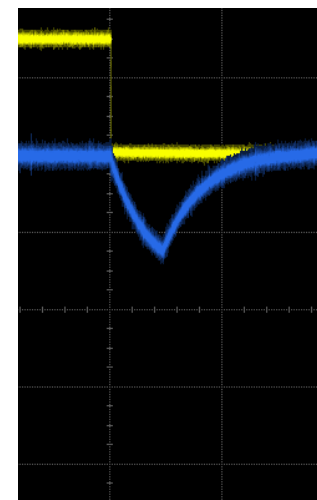


BEETLE readout chips

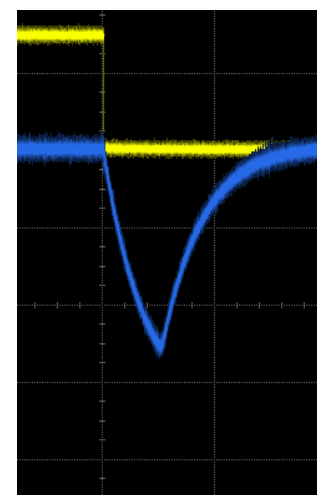
Pitch-adaptors HV2FEJ4 sensors



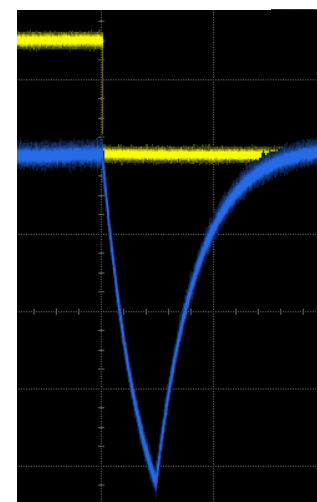
Pitch-adaptor



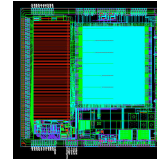
Row 0



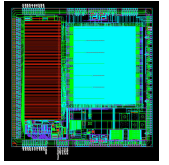
Row 12



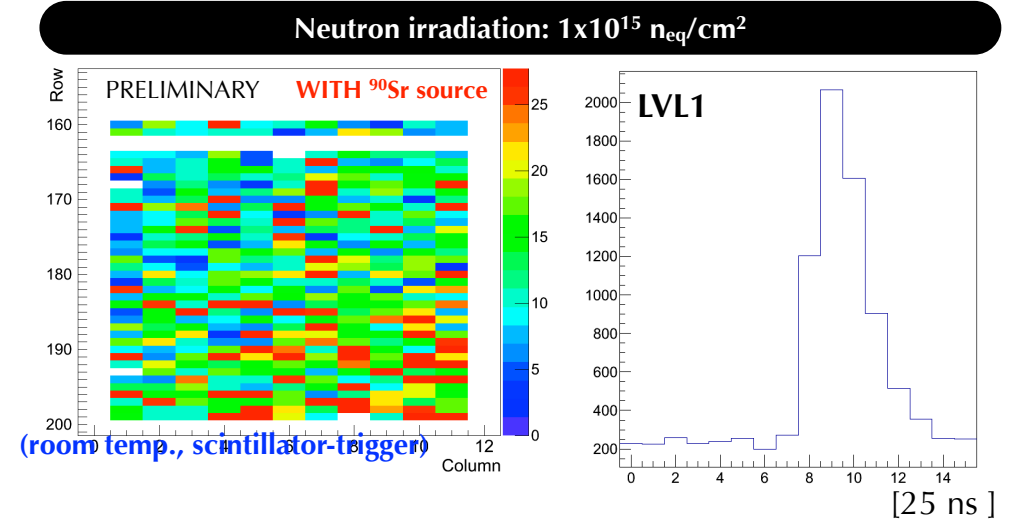
Row 23



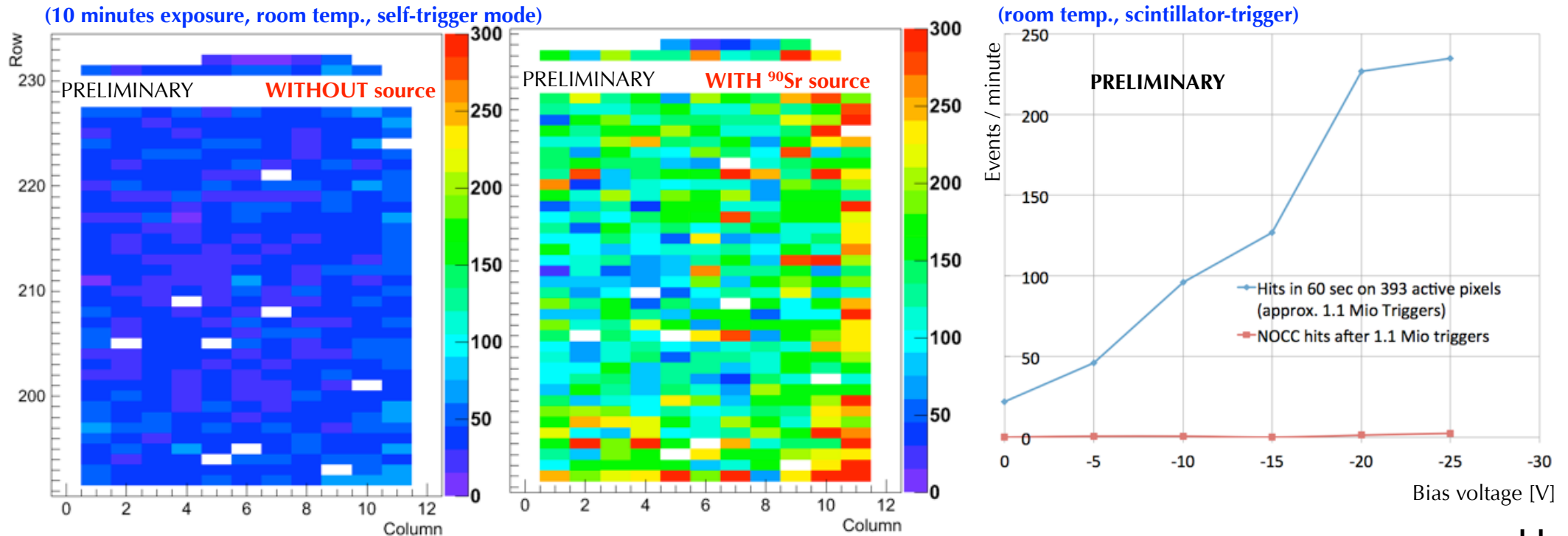
Irradiation results on HV2FEI4_v1 (1/2)



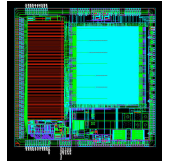
- Neutron irradiation (Ljubljana)
 - ▶ 10^{15} , 10^{16} n_{eq}/cm^2
- measurements with ^{90}Sr source
- Running conditions:
 - ▶ room temperature
 - ▶ bias voltage: ~ -20 V
 - ▶ self-trigger & scintillator



Neutron irradiation: 1×10^{16} n_{eq}/cm^2

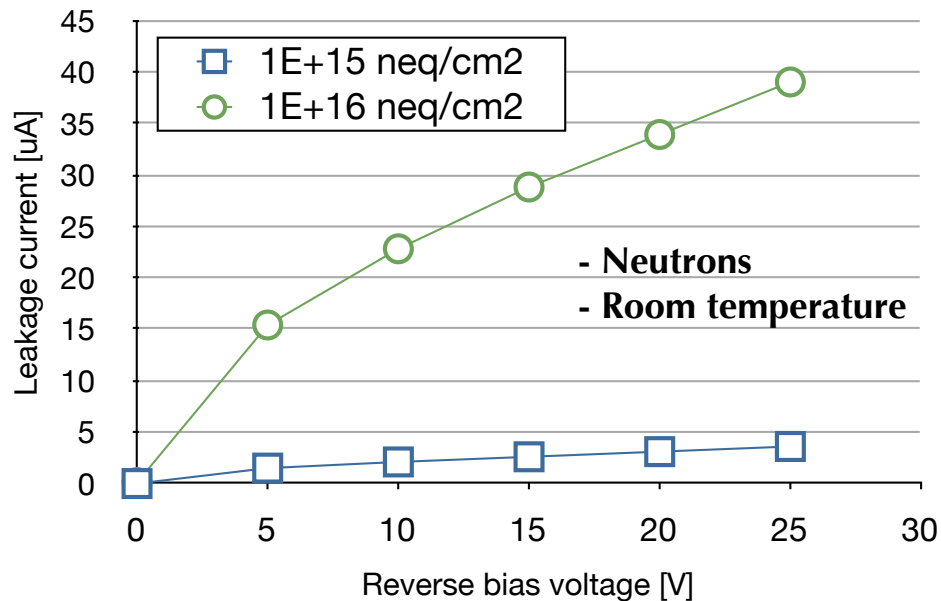


Irradiation results on HV2FEI4_v1 (2/2)

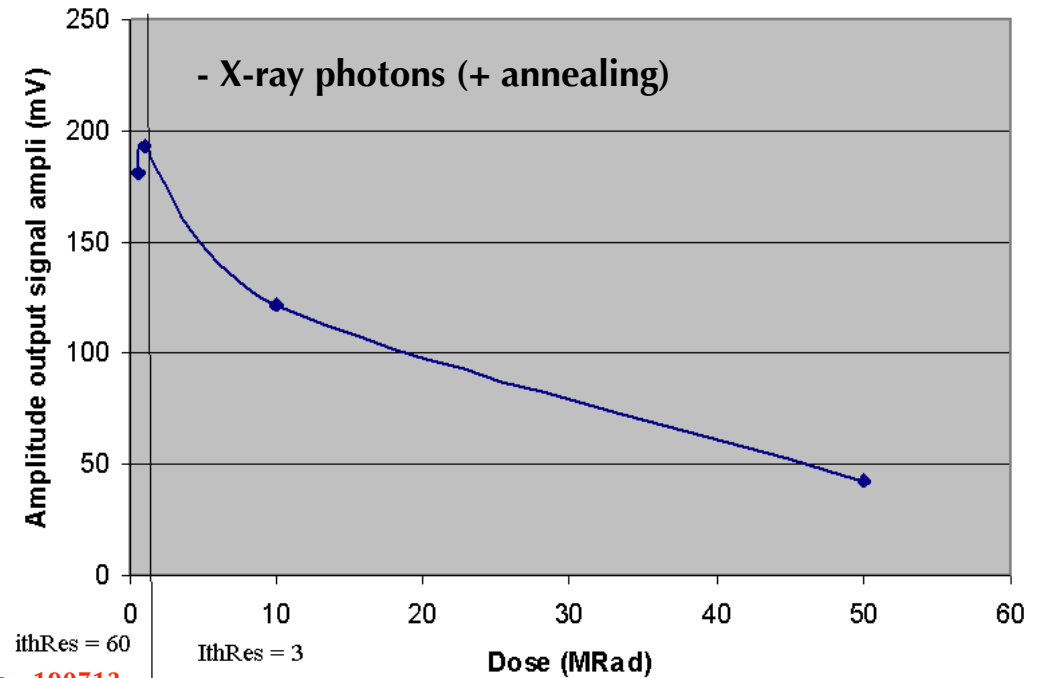


- Additional irradiations:
 - ▶ protons (CERN SPS)
 - ▶ X-rays (CERN) → up to 50 MRad
- First version of HV2FEI4 not fully rad-hard
 - ▶ expected !!
 - usage of standard cells
 - ▶ rad-hard wrt bulk damage

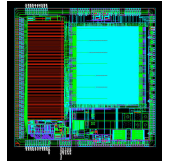
IV characteristics



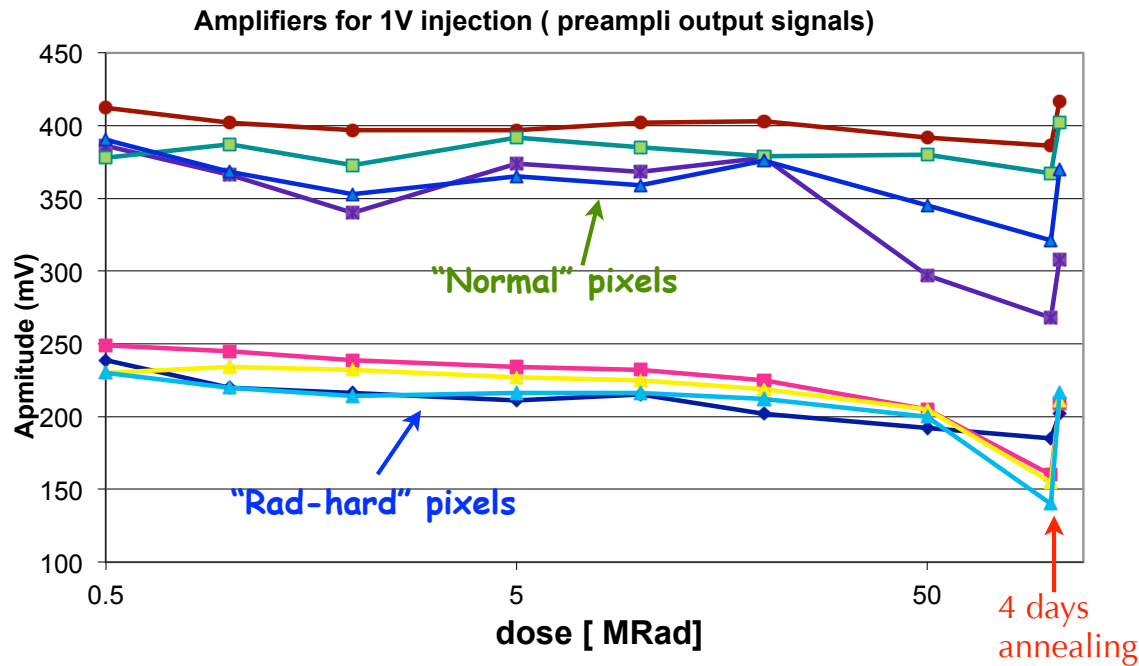
Amplifier output response to test-pulses (1 V)



HV2FEI4_v2



- Second version of the HV2FEI4 chip
 - ▶ more radiation tolerant
 - circular devices, guard rings, etc.
- First irradiation results (X-rays)
 - ▶ no significant degradation (50 MRad)



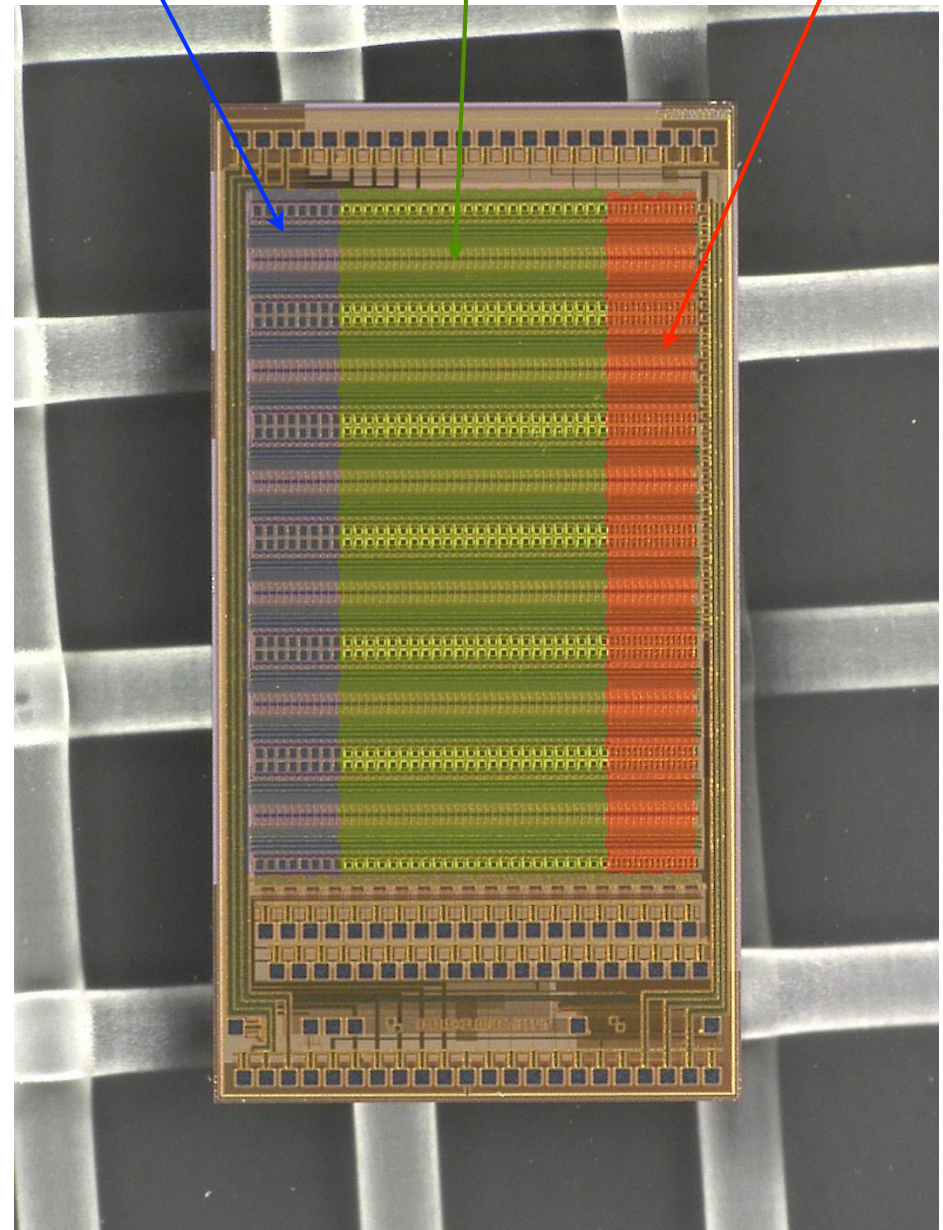
"Rad-hard" pixels

- ◆ Col 2x1 RadHard
- ◆ Col 5x1 RadHard
- ◆ Col 7x1 RadHard

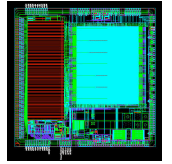
"Normal" pixels

- ◆ Col 9x1 RadHard
- ◆ Col 30x1 Normal
- ◆ Col 33x1 Normal

"Rad-hard" pixels "Normal" pixels "Simple" pixels



Summary



- First prototypes of HV2FEI4 chip fully working
 - ▶ Compatible with both pixel (AC & DC) readout, strip-readout
 - ▶ Very promising results so far:
 - ⦿ demonstration of sub-pixel encoding (CCPD) and position encoding (virtual strip)
 - ⦿ first prototype sensor (specifically non-radhard) alive after 10^{16} n_{eq}/cm² !!
 - ⦿ second version (HV2FEI4_v2) with improved radiation hardness
- HV-CMOS appears as a very promising technology for future particle tracking detectors in the HL-LHC
 - ▶ low-cost commercial technology, high-availability
 - ⦿ no bump-bonding needed !!
 - ▶ low-mass (thin) sensors, low-power, high SNR (even at room temperature)
 - ▶ rad-hard, improved spatial resolution
- Next steps:
 - ▶ more radiation-hardness studies
 - ▶ prototypes for ATLAS pixel and strip detector modules